Search Notes

Application/Control No	Applicant(s)/Patent under Reexamination	
10/584,143	KAMEYAMA ET AL.	
Examiner	Art Unit	
Hien D. Vu	2833	

	SEAR	CHED	
Class	Subclass	Date	Examiner
439	271 274 587 588 281 282	4/20/07	

INT	INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner		
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